

**Search Notes**

Application/Control No.

10/564,453

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

MASUDA ET AL.

Art Unit

1752

**SEARCHED**

Class	Subclass	Date	Examiner
430	190	6/2006	JSC
430	191		
430	192		
430	193		
430	326		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
430	190,191	6/2006	JSC
430	192		
430	193,326		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH IN FILE	6/2006	JSC
INVENTOR SEARCH		